

<b>Notice of References Cited</b>	Application/Control No. 10/022,081	Applicant(s)/Patent Under Reexamination LIOU ET AL.	
	Examiner Thomas Duong	Art Unit 2145	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,901,067 B1	05-2005	Kalavade, Asawaree P	370/352
*	B	US-6,445,679	09-2002	Taniguchi et al.	370/232
*	C	US-6,611,519	08-2003	Howe, Wayne R.	370/386
*	D	US-6,763,392	07-2004	del Val et al.	709/231
*	E	US-6,944,169 B1	09-2005	Yoshizawa et al.	370/410
*	F	US-7,120,122 B1	10-2006	Starr et al.	370/250
*	G	US-6,876,668 B1	04-2005	Chawla et al.	370/468
*	H	US-6,963,927 B1	11-2005	Lee et al.	709/241
*	I	US-6,236,909 B1	05-2001	Colson et al.	701/1
*	J	US-5,819,043	10-1998	Baugher et al.	709/222
*	K	US-6,700,893	03-2004	Radha et al.	370/412
*	L	US-6,987,730	01-2006	Hata et al.	370/232
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.